

Radiation tests

- Last test - PSI (December 2010)
 - DerivFIP -> found a weak component;
 - Calibration of Cypress memories (130 and 90 nm) for RADMON (new generation) -> analysis on going;
 - Calibration of Toshiba memories (400 nm) -> analysis on going;
- Tests for 2011
 - PSI - Villigen (Jan-Feb 2011)
 - Preparation of an agreement with PSI to get 1 weekend test per month;
 - Test of Amplifier, ADC buffers, and ADC for the PC redesign;
 - Continue calibration of memories for RADMONs.
 - CEA – Valduc (Feb 2011)
 - Calibration of PinDiodes (RADMON) for the Displacement Damage measurements.
 - CNRAD (Mar-Nov 2011)
 - Support for tests on Power converters, QPS equipment, and other ...
 - H4IRRAD (start May)
 - Support for tests on Power Converters, EN/EL equipment.